

**Search Notes**

Application/Control No.

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Examiner

Alex Liew

Applicant(s)/Patent under  
Reexamination

SHIBUYA ET AL.

Art Unit

2624

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
382/141-152 limited to text search	2/2/2007	AL
382/181-231 limited to text search	2/21/2007	AL
Consulted with Joseph Mancuso	2/21/2007	AL
Consulted with Samir Ahmed	2/22/2007	AL